Schedule to

CERTIFICATE OF ACCREDITATION



Client Number 8



Callaghan Innovation

Measurement Standards Laboratory of New Zealand

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Authorised Representative

Dr Blair Hall

Principal Research Scientist and Quality Manager

Programme

Metrology & Calibration Laboratory

Accreditation Number 1

Initial Accreditation Date 30 July 2004

Date:07/08/20

Page 1 of 23

Conformance Standard

ISO/IEC 17025:2017

Operations Manager

Authorisation:

General requirements for the competence of testing and calibration laboratories

1 \$10/8tro-

Laboratory Services Summary

5.01	Engineers' Limit Gauges			
5.02	Jigs, Fixtures, Cutting Tools and Components			
5.05	Geometric Form			
5.11	Working Standards of Length and Angle			
5.12	Precision Measuring Instruments			
5.14	Laser Frequency			
5.21	Masses			
5.31	Volumetric Equipment			
5.32	Density			
5.33	Hydrometers			
5.35	Hygrometry			
5.41	Barometers			
5.42	Differential Pressure Measuring Devices (including Manometers)			
5.43	Pressure Gauge Testers and Pressure Balances			
5.44	Pressure and Vacuum			
5.61	Temperature Measuring Equipment			
5.65	Photometers and Radiometers			
5.66	Lamps, LEDs, Lasers and Other Light Sources			
5.67	Colour of Light Sources and Colorimeters			
5.68	Optical Properties of Materials: Spectral			
5.69	Optical Properties of Materials: Spectrally integrated			
5.82	Resistors, Resistance Boxes and Potential Dividers			
5.84	Capacitors			
5.85	Inductors and Transformers			

Issue 57

Schedule to







5.86	Voltage Standards and Current Standards
5.87	Transfer Instruments (AC/DC)
5.88	Calibrators for Instrumentation
5.89	Indicating Instruments and Recording Instruments
5.90	Bridges, Potentiometers and Test Sets
5.91	Frequency Measurement and Time Measurement
5.92	Waveform Measurement
5.93	Signal Sources
5.97	High Voltage Testing

Approved Signatories

Dr Laurie Christian 5.82, 5.85(d), 5.86, 5.87, 5.88, 5.89, 5.90, 5.92(b), 5.93(b), 5.97

Dr Mark Clarkson 5.41, 5.42, 5.43, 5.44

Mr David Cochrane 5.05(d)(ii)

Dr Adam Dunford 5.91(a)(c)(d)(g), 5.92(a)(c), 5.93(a)

Dr Murray Early 5.82, 5.86, 5.87, 5.88, 5.89(a-d,i), 5.90(a,f,g), 5.92(b), 5.93(b), 5.97

Mr Hamish Edgar 5.61(j)(p)

Dr Lucy Forde 5.02, 5.05(d)(ii)(h), 5.11(f)(i)(n), 5.12, 5.14

Ms Eleanor Howick 5.01, 5.02, 5.05, 5.11, 5.12, 5.14

Mr Darrin Jack 5.41, 5.42, 5.43, 5.44

Mr Graeme Jonas 5.05(d)(ii)

Mr Keith Jones 5.82, 5.84, 5.85, 5.86, 5.87, 5.88(a,c,e), 5.89(a,c,e,f,g,h,i,l), 5.90,

5.92(b), 5.93(b), 5.97

Dr Annette Koo 5.68, 5.69

Dr Tim Lawson 5.82(a), 5.86(b), 5.88(c), 5.89(c)

Dr Jeremy Lovell-Smith 5.35

Mr Greg Reid 5.21, 5.31, 5.32, 5.33 Dr Peter Saunders 5.61, 5.82(a), 5.90(a)(c)

Dr Francois Shindo 5.65, 5.66, 5.67

Mr Tom Stewart 5.82(a), 5.84, 5.85(a,d), 5.88(b,d,e,f), 5.89(a,b,c,d-h,l), 5.90(c,f,g)

Mr Neil Swift 5.05(d)(ii), 5.65, 5.66, 5.67, 5.68, 5.69

Mr Yang Yenn Tan 5.65, 5.66(a)(e)(h), 5.68(a)(b)

Dr Emile Webster 5.61(a)(b)(c)(p)

Dr David Rodney White 5.35, 5.61, 5.82(a), 5.90(a)(c)
Mr Chris Young 5.01, 5.02, 5.05, 5.11, 5.12, 5.14

Operations Manager Authorisation:

1 HOBERO

Issue 57

Date:07/08/20

Page 2 of 23

Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

The uncertainty of a Calibration and Measurement Capability (CMC) is expressed as an expanded uncertainty with a level of confidence of approximately 95% Note1.

Measurement results are traceable to the International System of Units (SI)

Calibrations are generally performed at the premises of the accredited laboratory, although some may be carried out in the field and some at customer premises.

Measurand Conditions CMC Uncertainty

5.01 Engineers' Limit Gauges

(a) Plain plug, ring and gap gauges. Taper plug and ring gauges.

Setting plug gauges by comparison with gauge blocks

Mean diameter 0.5 mm to 25 mm Q(130, 1.4L) nm, L in mm Mean diameter 25 mm to 300 mm Q(95, 1.8L) nm, L in mm

Setting ring gauges by comparison with gauge blocks

Mean diameter 1 mm to 300 mm Q(95, 1.8L) nm, L in mm

Where $Q(a,b) = \sqrt{a^2 + b^2}$

(e) Position and receiver gauges involving both linear and angular measurements.

Lobster tail gauges 54 mm to 60 mm 0.01 mm

(g) Other gauges involving measurements similar to those under (a) and including depth gauges, height gauges and gauges involving plane coordinated position of holes and spigots.

Step gauge face spacing by comparison with end standards on CMM

90 mm to 700 mm Q(0.7, 1.2 x $10^{-3}L$) µm, L in mm

2D CMM artefacts (ball plate centre coordinates) by comparison with end standards on CMM

Side length between 100 mm and 600 mm $Q(0.9, 1.3 \times 10^{-3} L) \mu m$, L in mm

5.02 Jigs, Fixtures, Cutting Tools and Components

Measurement of components/objects on CMM

Operations Manager Authorisation: Issue 57 Date:07/08/20 Page 3 of 23

Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Error of indicated size

1 mm to 800 mm

 $(1.6 + 3.5L) \mu m, L in m$

Measurement of components/objects on Profile Projector

Error of indicated size up to 200 mm x 200 mm

Q(0.76, 12.6L) µm, L in m

5.05 Geometric Form

(b) Roundness

Variability in roundness Range of diameters

0 μm to 400 μm 1 mm to 300 mm Q(0

 $Q(0.025, 0.018R) \mu m, R in \mu m$

(d) Flatness of Optical Flat, Parallelism, Wedge Angle of Optical Wedge or Flat

i) Length section

Parallelism Range of diameters

Range of diameters

Flatness

ii) Photometry section

Flatness of optical flats, one-axis or whole surface

Up to 150 mm diameter 22 nm Up to 250 mm diameter 33 nm

(h) Levelness

Levelling of dynamic weigh station sites by measurement of deviation from a horizontal plane (calibration carried out on site)

Deviation in height Horizontal range

1.8 m to 60 m

Q(41, 7.1L) μ m, L in m is the horizontal distance to staff

5.11 Working Standards of Length and Angle

(a) Gauge blocks and accessories

Measurement of central length

By interferometry 0.5 mm to 103 mm Q(17, 0.15L) nm, L in mm

Operations Manager Authorisation: AGOPTIO

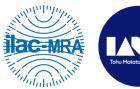
Issue 57

Date:07/08/20

Page 4 of 23

Schedule to

CERTIFICATE OF ACCREDITATION



Callaghan Innovation Metrology & Calibration Laboratory

Accreditation Number 1

SCOPE OF ACCREDITATION

By comparison 0.1 mm to 103 mm Q(36, 1.4L) nm, L in mm

Measurement of variation in length

Q(30, 0.35*L*) nm, *L* in mm

Length bars and accessories (b)

Measurement of central length and variation in length

Long gauge blocks by comparison with gauge blocks using the Horizontal Federal

100 mm to 300 mm

Q(91, 1.3L) nm, L in mm

Measurement of variation in length

Q(34, 0.35*L*) nm, *L* in mm

Long gauge blocks by comparison with gauge blocks using the LBC

100 mm to 1500 mm

Q(370, 0.48L) nm, L in mm

Measurement of variation in length

100 nm

(f) Precision linear scales

Engineer or machinist scale-line spacing

0.1 m to 4 m

Q(10, 8.2*L*) µm, *L* in m

Precision graticules including stage micrometers and haemocytometer counting (h) chambers

1 µm to 10 mm

0.5 µm

Surveying tapes and petroleum dip tapes (i)

4 m to 50 m

 $Q(10, 10.5L) \mu m, L in m$

Surveyor levelling rods

0.5 m to 3 m

 $Q(10, 10L) \mu m, L in m$

Geodetic Baselines (calibrations carried out on site) (n)

Interval distances

2 m to 1500 m

 $Q(0.3, 0.6 \times 10^{-3}L)$ mm, L in m

5.12 **Precision Measuring Instruments**

Length measuring machines (a)

Operations Manager 1/10/800-Issue 57 Date:07/08/20 Page **5** of **23** Authorisation:

Schedule to





				MILITAN.
Metrology	Callaghan Innovation Metrology & Calibration Laboratory SCOPE OF ACCREDITATION Accreditation Number 1			
	Electro	nic distance mea	suring machines (EDMs)	
	Error o	f indicated ement	1 m to 206 m	Q(0.13, 7 x 10 ⁻⁴ <i>L</i>) mm, <i>L</i> in m
	Error o	f indicated ncy	5 MHz to 100 MHz	0.16 x 10 ⁻⁶ L x frequency
	Error o	f prism constant		0.26 mm
5.14	Laser	Frequency		
	(a)	Stabilised lase	rs of the mise en pratique	
	Absolu	te frequency	473 612 GHz	25 kHz
	(b)	Other stabilise	d lasers	
	Absolu	te frequency	473 612 GHz	0.2 MHz
5.21	Mass	es		
	(a) (b) (c)	Examination of	laboratory standards of mass industrial standards of mass of the mass of solid objects	
	0.1 g to 1 g to 10 g to 0.1 kg 1 kg to 10 kg t 20 kg t	10 g 100 g to 1 kg		0.4 µg to 0.7 µg 0.7 µg to 1.6 µg 1.6 µg to 4 µg 4 µg to 8 µg 8 µg to 40 µg 1.1 x 10 ⁻⁷ 1.6 x 10 ⁻⁷ 1.5 x 10 ⁻⁶ 10 g to 16 g
5.31	Volun	netric Equipm	ent	
	(a)		laboratory volumetric glassware inc A or Class B requirements of the rele	
	0.02 m	L to 2 mL		0.0002 mL
	(b)	Examination of	other types of volumetric apparatus	
	0.002 l	_ to 50 L		0.01 %

Schedule to





Callaghan Innovation Metrology & Calibration Laboratory SCOPE OF ACCREDITATION			Accreditation	Number 1	
5.32	Density	y			
	(a)	Density of solids			
	1400 kg/ 7800 kg/	/m³ to 3000 kg/m³ /m³ to 8200 kg/m³		1.0 x 10 ⁻⁵ 1.5 x 10 ⁻⁵	
	(b)	Density of liquids			
	600 kg/n	n³ to 2000 kg/m³		2.0 x 10 ⁻⁵	
5.33	Hydror	neters			
	(a) (b) (c) (d)	Density hydrometers Specific gravity hydrometers Brix hydrometers Proof spirit hydrometers			
	600 kg/n	n ³ to 2000 kg/m ³		2.0 x 10 ⁻⁵	
5.35	Hygrometry				
	(a)	Humidity measuring devices			
	i)	Dew point hygrometers			
	-70 °C to 0 °C 0 °C to 40 °C 40 °C to 70 °C			0.2 °C to 0.06 °C 0.06 °C 0.06 °C to 0.12 °C	
	ii)	Relative humidity hygrometers			
	10 % to (Temper	95 % rature between 0 °C and 70 °C)		0.006 x h % h is relative humidi as a percentage, th	
	iii)	Air temperature		as a porcernage, a	
	0 °C to 7	70 °C		0.1 °C	
5.41	Barom	etric indicators or transduc	ers		
	Aneroid	barometers (including digital baro	meters)		
50 kPa to 90 kPa 2.0 x 10 ⁻⁵ 90 kPa to 110 kPa 1.0 x 10 ⁻⁵ 110 kPa to 130 kPa 2.0 x 10 ⁻⁵					
Operations Manager Authorisation: Issue 57 Date:07/08/20 Page 7 of 23				Page 7 of 23	

Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

5.42 Differential Pressure Measuring Devices (including Manometers)

- (a) Diaphragm types
- (b) Liquid column types, inclined and vertical
- (c) Transducers and transmitters
- (d) Other types

1 Pa to 10000 Pa

 $(6 \times 10^{-3} + 4.5 \times 10^{-5} p)$

Pa, p in Pa

5.43 Pressure Gauge Calibrators and Pressure Balances

i) Absolute pressure – gas medium

8 kPa to 550 kPa 2 x 10⁻⁵ 550 kPa to 7000 kPa 6 x 10⁻⁵

ii) Gauge pressure – gas medium

-100 kPa to -10 kPa 7×10^{-5}

-10 kPa to -1 kPa 200 mPa to 100 mPa, decreasing linearly

1 kPa to 8 kPa

100 mPa to 160 mPa, increasing linearly

8 kPa to 550 kPa 2 x 10⁻⁵ 550 to 11000 kPa 6 x 10⁻⁵

iii) Gauge pressure – liquid medium

0.1 MPa to 17 MPa $(1 \times 10^{-4} + 6.6 \times 10^{-5}p)$

MPa (p in MPa)

17 MPa to 280 MPa $(6.6 \times 10^{-5}p + 7 \times 10^{-7}p^{2})$

MPa (p in MPa)

5.44 Pressure and Vacuum

(a) Pressure gauges

(b) Vacuum gauges

(c) Pressure transducers

(d) Pressure recorders

i) Absolute pressure – gas medium

 8 kPa to 90 kPa
 2×10^{-5}

 90 kPa to 110 kPa
 1×10^{-5}

 110 kPa to 550 kPa
 2×10^{-5}

Operations Manager Authorisation: AGOPTIO

Issue 57

Date:07/08/20

Page 8 of 23

Schedule to





	/ & Calib	tion ration Laboratory REDITATION	Accreditation Number 1
	550 kF	Pa to 7000 kPa	6 x 10 ⁻⁵
	ii)	Gauge pressure – gas medium	
	8 kPa 90 kPa 110 kF	Pa to 8 kPa to 90 kPa a to 110 kPa Pa to 550 kPa o 11000 kPa	0.0031 kPa 2 x 10 ⁻⁵ 1 x 10 ⁻⁵ 2 x 10 ⁻⁵ 6 x 10 ⁻⁵
	iii)	Absolute pressure – liquid medium	
		Pa to 17 MPa Pa to 280 MPa	(1 x 10^{-4} + 6.6 x $10^{-5}p$) MPa (p in MPa) (6.6 x $10^{-5}p$ + 7 x $10^{-7}p^2$) MPa (p in MPa)
	iv)	Gauge pressure – liquid medium	wii a (p iii wii a)
		Pa to 17 MPa	$(1 \times 10^{-4} + 6.6 \times 10^{-5}p)$ MPa (p in MPa) $(6.6 \times 10^{-5}p + 7 \times 10^{-7}p^2)$
			MPa (p in MPa)
5.61	Temp	perature Measuring Equipment	
	(a)	Noble-metal thermocouples	
		o 962 °C C to 1100 °C	0.026 °C 0.22 °C
	(b)	Base-metal thermocouples	
	0 °C t	o 1100 °C	1.6 °C
	(c)	Platinum (and other metallic) resistance thermometer	ers
	Contact thermometers, including Standard PRTs at the fo		ing fixed points
	Argon triple point (-189.3442 °C) Mercury triple point (-38.8344 °C) Water triple point (0.01 °C) Gallium melting point (29.7646 °C) Indium freezing point (156.5985 °C) Tin freezing point (231.928 °C) Zinc freezing point 419.527 °C)		1 mK 0.4 mK 0.1 mK 0.19 mK 0.56 mK 0.85 mK 1.9 mK

Operations Manager Authorisation:	1HOPETO-	Issue 57	Date:07/08/20	Page 9 of 23
--------------------------------------	----------	----------	---------------	----------------------------

Schedule to



	& Calibra	on ation Laboratory EDITATION	Accreditation Number 1
		ium freezing point (660.323 °C) reezing point (961.78 °C)	10 mK 20 mK
	(j)	Radiation thermometers	
	Direct r	reading, single spot radiation thermometers and therma	l imagers
	-25 °C	to 1100 °C	0.6 °C
	(p)	Other direct reading temperature measuring systems	, including Industrial PRTs
	0 °C to	C to 0 °C 200 °C to 550 °C	(2.4 - 0.005 x t) mK, t in °C (2.4 + 0.008 x t) mK, t in °C (4.0 + 0.03 x (t – 200)) mK, t in °C
5.65	Photo	meters and Radiometers	
	(a)	Photometers	
	10 lux 1	to 3000 lux	0.8 %
	(b)	Illuminance meters	
	10 lux 1	ux to 10 lux to 3000 lux ux to 30000 lux	3 % 0.8 % 3 %
	(c)	Luminance meters	
	800 cd	m ² to 800 cd/m ² /m ² to 27000 cd/m ² cd/m ² to 33000 cd/m ²	1.6 % 7 % 11 %
	(d)	UV meters	
	For Irra	adiance levels of 1 µW.cm ⁻² to 5000 µW.cm ⁻²	
	270 nm 310 nm	n to 270 nm n to 310 nm n to 380 nm	5 % 2.3 % 2.5 %
	For rac	diant exposure levels greater than 1.3 µJ.cm ⁻²	
	240 nm	n to 270 nm	20 % to 5 %, decreases with exposure time

Operations Manager Authorisation:	1HORTO-	Issue 57	Date:07/08/20	Page 10 of 23
--------------------------------------	---------	----------	---------------	-----------------------------

Schedule to





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Metrology	n Innovation A Calibration Laboratory OF ACCREDITATION	Accreditation Number 1
	270 nm to 310 nm	19 % to 2.3 %, decreases with
	310 nm to 380 nm	exposure time 19 % to 2.5 %, decreases with exposure time
	(g) Laser power meters	
	Laser lines from 450 nm to 500 nm	0.45 % to 0.23 %, decreases linearly with wavelength
	Laser lines from 500 nm to 550 nm	0.23 % to 0.15 %, decreases linearly with wavelength
	Laser lines from 550 nm to <650 nm	0.15 %
	Laser lines from 650 nm to 750 nm	0.17 %
	Laser lines from 750 nm to 800 nm	0.19 %
	(h) Detector spectral responsivity measurement	
	Discrete wavelengths	
	Laser lines from 450 nm to 500 nm	0.45 % to 0.23 %, decreases linearly with wavelength
	Laser lines from 500 nm to 550 nm	0.23 % to 0.15 %, decreases linearly with wavelength
	Laser lines from 550 nm to <650 nm	0.15 %
	Laser lines from 650 nm to 750 nm	0.17 %
	Laser lines from 750 nm to 800 nm	0.19 %
	The below CMCs are for spectral power levels of 0.1 µW.nm ⁻¹	to 10 µW.nm ⁻¹ and
	corresponding irradiance levels using appropriate apertures. F 0.1 µW.nm ⁻¹ uncertainties will increase.	For spectral power levels below
	240 nm to <300 nm	1.4 %
	300 nm to <340 nm	0.98 %
	340 nm to 360 nm	1.02 % to 0.98 %, decreases linearly with wavelength
	360 nm to 380 nm	0.98 %
	380 nm to 450 nm	0.98% to 0.45%, decreases linearly with wavelength
	450 nm to 800 nm	Same as for discrete wavelengths – see (g) above
	800 nm to 950 nm	0.19% to 0.33%, increases linearly with wavelength
5.66	Lamps, LEDs, Lasers and Other Light Sources	

Operations Manager Authorisation:	11 11 1 1 1 VV 1 2 1 1	Issue 57	Date:07/08/20	Page 11 of 23	
--------------------------------------	------------------------	----------	---------------	-----------------------------	--

Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Calibrations within 5.66 may be offered in the field as well as in the laboratory. An increase in uncertainty due to environmental conditions and other influence variables present in the field may need to be applied.

(a) Lamps: luminous intensity

10 cd to 5000 cd 0.8 %

(e) Illuminance

0.005 lux to 30000 lux 3 %

(f) General sources: spectral irradiance

250 nm to 350 nm 0.0001 W/(m².nm) to 2.6 % to 1.6 %

 $0.5 \text{ W/(m}^2.\text{nm})$

350 nm to 850 nm 0.001 W/(m².nm) to 1.6 % to 1.4 %

 $0.5 \text{ W/(m}^2.\text{nm})$

(h) Photoluminescent materials

from 0.5 mcd/m^2 $0.5 \text{ mcd/m}^2 \text{ or } 15 \%$,

whichever is greater

5.67 Colour of Light Sources and Colorimeters

Calibrations within 5.67 may be offered in the field as well as in the laboratory. An increase in uncertainty due to environmental conditions and other influence variables present in the field may need to be applied.

(a) General sources:

Colour emitted in CIE x, y colour space 0.0005 to 0.005 in x and y,

varies with measurand

Colour emitted in CIE u, v colour space 0.0007 in u and v

(d) Lamps:

Correlated colour temperature 2700 K to 3000 K 20 K

5.68 Optical Properties of Materials: Spectral

(a) Regular transmittance (T) and optical density or absorbance (OD)

Bandwidth 1 nm to 3 nm

Operations Manager Authorisation: Issue 57 Date:07/08/20 Page 12 of 23

Schedule to

CERTIFICATE OF ACCREDITATION





		aumn.
Callaghan Innovation Metrology & Calibration Laboratory SCOPE OF ACCREDITATION		Accreditation Number 1
240 nm to 380 nm	T = 0.0001 to 0.01	0.0002.T ^{0.2}
380 nm to 1000 nm 240 nm to 380 nm	T = 0.01 to 1.0 T = 0.0001 to 1.0 OD = 2 to 4	0.005.T 0.0007.T ^{0.65} 0.000087.10 ^{0.8.OD}
380 nm to 1000 nm	OD = 0 to 2 OD = 0 to 4	0.0022 0.00031.10 ^{0.35.OD}
(b) Wavelength cali	bration filters	
240 nm to 800 nm		0.13 nm
800 nm to 1100 nm		0.13 nm to 0.25 nm
(c) Diffuse transmit	tance	
240 nm to 400 nm		0.005 to 0.0002 or 5 % of value whichever is greater
400 nm to 1000 nm		0.0002 or 5 % of value whichever is greater
(d) Diffuse reflectar	nce in 0/d and 6/d geometries	
360 nm to 1000 nm	0.016 to 0.9	0.008 to 0.0036, varies with wavelength
360 nm to 1000 nm	0.9 to 1.0	0.4 % of value
(e) Specular reflect	ance at normal incidence	
240 nm to 800 nm	0.05 to 1	1 % of value
(f) Bidirectional reflecta	nce distribution factor and bidirecti	onal radiance factor
In plane geometries only	, 0.001 sr ⁻¹ to 2500 sr ⁻¹	
360 nm to 400 nm		1.5 % of value
400 nm to 700 nm 700 nm to 820 nm		0.5 % of value 1.5 % of value
Representative CMCs are		ectralon only. Measurement uncertainty ar dependence of scattering properties

5.69 Optical Properties of Materials: Spectrally integrated

(a) Luminous transmittance

Spectrally flat materials

0.3 % of value
General materials

5 % of value

Operations Manager Authorisation:	1 HOBELO-	Issue 57	Date:07/08/20	Page 13 of 23
--------------------------------------	-----------	----------	---------------	-----------------------------

Schedule to





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	/ & Calib	tion ration Laboratory REDITATION	Accreditation Number 1
	(b)	Luminous reflectance	
	Gener	ral materials	5 % of value
	(c)	Colour transmitted, x, y, Y or L*a*b*	
	In x ar Lumin	nd y ous transmittance Y for (0.1 < Y < 1)	0.005 5 % of value
	(d)	Colour of surfaces, x, y, Y or L*a*b*	
	In x ar Lumin	nd y ance factor Y for (0.1 < Y < 1)	0.003 5 % of value
	(e)	Retroreflectors: CIL value	
	Coeffi	cient of luminous intensity	5 %
5.82	Resis	stors, Resistance Boxes and Potential Divider	s
	(a)	Precision resistors, resistance boxes and conductance	ce boxes
		to 1 Ω	0.2 μΩ/Ω
	ÌΩ to	ent ≤ 100 mA) o 10 kΩ er dissipation ≤ 10 mW)	0.12 μΩ/Ω
		Ω to 1000 mΩ ent ≤ 1A)	25 μΩ/Ω
		Ω to 1000 m $Ω$ ent = 1 A to 875 A)	63 $R^{-0.35}$ μΩ/Ω, R in mΩ values range from 141 μΩ/Ω to 6 μΩ/Ω
		$M\Omega$ to 1 $M\Omega$ ed voltages = 5 V to 100 V)	0.7 μΩ/Ω
		$G\Omega$ to 1 $G\Omega$ ed voltages = 5 V to 100 V)	$(0.7 + 27~R - 20~R^3)$ μ Ω/Ω , R in $G\Omega$, values range from 0.7 μ Ω/Ω to 8 μ Ω/Ω
		to 5 T Ω ed voltages = 100 V to 1000 V)	$(35 + 6.9 \times 10^{-11} \ R^2 + 9.4 \ \mu\Omega/\Omega \times 10^{-4} R) \ \mu\Omega/\Omega$, $R \ \text{in } M\Omega$, values range from 35 $\mu\Omega/\Omega$ to 6460 $\mu\Omega/\Omega$
	0 ΜΩ	to 1 MΩ	(2000/f + 19 R) $\mu\Omega$, f in Hz,

Operations Manager Authorisation:	Issue 57	Date:07/08/20	Page 14 of 23
--------------------------------------	----------	---------------	-----------------------------

Schedule to



Metrology	Callaghan Innovation Metrology & Calibration Laboratory SCOPE OF ACCREDITATION Accreditation Number 1			
	(frequ	iency, f = 40 Hz to 2 kHz)	R in $\Omega,$ values range from 1 μΩ to 19 Ω	
	(b)	Volt ratio boxes and potential dividers		
		to 1000 V/V voltage ≤ 1100 V, output voltage ≥ 1 V)	0.4 x 10 ⁻⁶	
	0 kV t	to 50 kV	3 mV/V	
	(c)	DC shunts		
	(Appli	Ω to 1 Ω ied current 1 A to 875 A) ied voltage 10 mV to 1 V)	63 $R^{0.35}$ μΩ/Ω, R in mΩ values range from 141 μΩ/Ω to 6 μΩ/Ω	
	(d)	AC shunts		
		Ω 100 Ω sency, f = 40 Hz to 2 kHz)	(2000/ f + 19 R) μ Ω , f in Hz, R in Ω , values range from 1 μ Ω to 1900 μ Ω	
	-	to 100 A sency, $f = 47$ Hz to 75 Hz)	25 μΩ/Ω	
5.84	Capa	acitors		
	(a)	Precision capacitors		
		to 100 µF nency, f = 40 Hz to 2 kHz)	$(0.2/f + 22C)$ pF, f in Hz, C in μ F, values range from 0.0001 pF to 2200 pF	
	0 to 0 (frequ	pation factor .2 section $f = 40 \text{ Hz}$ to 2 kHz) citance, $C = 0.5 \text{ pF}$ to 100 μF)	(0.000027 + 0.00027/C) C in pF values range from 0.00057 to 0.000027	
	(c)	Capacitance potential dividers		
		rms to 35 kV rms lency, $f = 50$ Hz to 3 kHz)	1 mV/V	
5.85	Indu	ctors and Transformers		
	(a)	Inductors, self and mutual		

Schedule to





Metrology	Callaghan Innovation Metrology & Calibration Laboratory SCOPE OF ACCREDITATION Accreditation Number 1				
	0 H to 100 H (frequency, f = 40 Hz to 2 kHz)	(0.2/f + 14 <i>L</i>)H μH, <i>f</i> in Hz <i>L</i> in H, values range from 0.0001 μH to 1400 μH			
	Equivalent series resistance 0 Ω to 1 M Ω (frequency, f = 40 Hz to 2 kHz)	(2000/ f + 19 R) μ Ω , f in Hz, R in Ω , values range from 1 μ Ω to 19 Ω			
	(d) Current transformers: protection and measurement				
	Primary currents 1 A to 4000 A, ratios 0.2 A/A to 4000 A/A				
	Ratio error -25 % to 25 % Phase error -36 crad to 36 crad (frequency, f = 50 Hz; secondary currents 1 A, 5 A)	0.0010 % to 0.13 % 0.0010 crad to 0.18 crad			
5.86	Voltage Standards and Current Standards				
	(b) Electronic emf reference devices				
	1 V 1.018 V 10 V	0.1 μV 0.1 μV 1.5 μV			
5.87	Transfer Instruments (AC/DC)				
	0.002 V to 0.6 V > 0.6 V to 6 V > 6 V to 1000 V (frequency, f = 10 Hz to 1 MHz)	11 μV/V to 321 μV/V 6 μV/V to 77 μV/V 9 μV/V to 76 μV/V			
	1 V and 3 V (frequency, $f = 1$ MHz to 100 MHz)	0.16 mV/V to 2.6 mV/V			
	0.1 mA to 0.01 A (frequency, $f = 40$ Hz to 2 kHz)	15 μA/A to 38 μA/A			
	0.01 A to 20 A (frequency, <i>f</i> = 40 Hz to 100 kHz)	15 μA/A to 70 μA/A			
5.88	Calibrators for Instrumentation				
	(a) DC voltage				
	0 V to 12 V	(0.05 + 0.15 <i>U</i>) μV, <i>U</i> in V, values range from 0.05 μV to			
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Operations Manager Authorisation:	150/sto-	Issue 57	Date:07/08/20	Page 16 of 23
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Schedule to



Metrology	Innovation & Calibration Laboratory F ACCREDITATION	Accreditation Number 1
	12 V to 1100 V	1.85 μV 0.5 μV/V
	(b) AC voltage	
	0.002 V to 1000 V (frequency, $f = 10$ Hz to 1 MHz)	6 μ V/V to 650 μ V/V
	1 V and 3 V (frequency, $f = 1$ MHz to 100 MHz)	0.3 mV/V to 8 mV/V
	(c) DC current	
	10 pA to 10 μA 10 μA to 1 A 1 A to 20 A 20 A to 1000 A	values range from 5 μ A/A to 560 μ A/A 5 μ A/A 5 μ A/A 5 $I^{0.43}$ μ A/A, I in A, values range from 5 μ A/A to 18 μ A/A 5 $I^{0.43}$ μ A/A, I in A, values
	(d) AC current	range from 18 μA/A to 97 μA/A
	0.1 mA to 2 A (frequency, $f = 40$ Hz to 2 kHz) 0.01 A to 100 A (frequency, $f = 47$ Hz to 75 Hz)	35 μA/A to 170 μA/A 25 μA/A
	(e) Resistance	
	0 Ω to 10 Ω 0.01 k Ω to 1 M Ω 1 M Ω to 100 M Ω	40 μ Ω 3 μ Ω/Ω (2 + $R^{0.8}$) μ Ω/Ω , R in M Ω , values range from 3 μ Ω/Ω to 42 μ Ω/Ω
	(f) AC power sources	
	Same as 5.89 (e) and (f)	
5.89	Indicating Instruments and Recording Instruments	3
	(a) DC voltmeters	
	0 V to 0.001 V 0.001 V to 12 V	0.05 μV (0.05 + 0.15 <i>U</i>) μV, <i>U</i> in V,

Operations Manager Authorisation:		Issue 57	Date:07/08/20	Page 17 of 23	
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Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation
Metrology & Calibration Laboratory

Accreditation Number 1

values range from 0.05 µV to

1.85 µV

12 V to 1100 V $0.5 \,\mu V/V$

AC voltmeters (b)

SCOPE OF ACCREDITATION

(c)

0.002 V to 1000 V $9 \mu V/V$ to $862 \mu V/V$

(frequency, f = 10 Hz to 1 MHz) 1 V and 3 V 0.3 mV/V to 8 mV/V

(frequency, f = 1 MHz to 100 MHz) DC ammeters

10 pA to 10 µA values range from

5 μA/A to 560 μA/A $10 \mu A$ to 1 A5 µA/A

 $5 \dot{I}^{0.43} \mu A/A$, I in A, values 1 A to 20 A range from 5 µA/A to 18µA/A

20 A to 875 A 5 *I*^{0.43} μA/A, *I* in A

values range from 18 µA/A to

92 µA/A

(d) AC ammeters

0.1 mA to 2 A 60 μA/A to 140 μA/A

(frequency, f = 40 Hz to 2 kHz) 0.2 A to 100 A 25 µA/A

Wattmeters (e)

(frequency, f = 47 Hz to 75 Hz)

Conditions

Voltage 60 V to 240 V, current 0.01 A to 120 A, frequency 45 Hz to 75 Hz, and PF 1 to 0, inductive or capacitive

Single phase

0 W to 28.8 kW (40 μW/VA+ 6(1-*PF*)), values

range from 40 µW/VA to

46 µW/VA

Three phase

0 W to 86.4 kW $(40 \mu W/VA + 6(1-PF))$, values

range from 40 µW/VA to

46 µW/VA

(The CMC range and uncertainties for star and delta are the same as for single-phase)

Operations Manager 1/10/8000 Issue 57 Date:07/08/20 Page **18** of **23** Authorisation:

Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

(f) Varmeters

Conditions

Voltage 60 V to 240 V, current 0.01 A to 120 A, frequency 45 Hz to 75 Hz, and QF1 to 0, inductive or capacitive

0 W to 28.8 kW

(40 μVar/VA + 90 QF), values range from 40 μVar/VA to 130 μVar/VA

0 W to 86.4 kW

(40 μ Var/VA + 90 QF), values range from 40 μ Var/VA to 130 μ Var/VA

(g) Phase angle indicators (source or meter)

Conditions

Current 0.01 A to 100 A, frequency 45 Hz to 75 Hz, Voltage 0.7 V to 7 V, 42 V to 240 V

-3.14 rad to 3.14 rad

40 µrad

(h) Power factor meters

Same conditions, CMC range and uncertainties as 5.89 (g) above

(i) Ohmmeters

 $0.1 \text{ m}\Omega$ to $1000 \text{ m}\Omega$ (applied current 875 A to 1 A)

0.1 Ω to 1 Ω (applied current ≤100 mA) 1 Ω to 10 k Ω 10 k Ω to 1 G Ω

1 G Ω to 100 G Ω

100 G Ω to 1200 G Ω

 $63R^{0.35}$ μΩ/Ω, R in mΩ, values range from 141 μΩ/Ω to

 $\begin{array}{l} 6 \; \mu \Omega / \Omega \\ 0.2 \; \mu \Omega / \Omega \end{array}$

 $0.12 \mu\Omega/\Omega$

 $(1 + 27R - 20R^3)$ μΩ/Ω, R in GΩ, values range from 1

 $\mu\Omega/\Omega$ to 8 $\mu\Omega/\Omega$

 $(-0.07R^2 + 22R - 15) \mu\Omega/\Omega$, R in G Ω , values range from

R in GΩ, values range from 6.9 $\mu\Omega/\Omega$ to 1485 $\mu\Omega/\Omega$ (1300R + 2.2R) $\mu\Omega/\Omega$, R in GΩ, values range from

1520 $\mu\Omega/\Omega$ to 3940 $\mu\Omega/\Omega$

(k) Galvanometers and null detectors

Same CMC range and uncertainties from 5.89 (a) DC voltmeters

Operations Manager Authorisation: Issue 57 Date:07/08/20 Page 19 of 23

Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation Metrology & Calibration Laboratory **SCOPE OF ACCREDITATION**

Accreditation Number 1

(l) Energy meters

Same as 5.89 (e) and (f)

5.90 **Bridges, Potentiometers and Test Sets**

(a) DC bridges

Same as 5.89 (i) Ohmmeters above

(b) DC potentiometers

Same as 5.89 (a) DC Voltmeters above

AC bridges (frequency, f = 40 Hz to 2 kHz) (c)

 0Ω to $1 M\Omega$ $(2000/f + 19R) \mu\Omega$, f in Hz,

R in Ω , values range from 1

 $\mu\Omega$ to 19 Ω

(0.2/f + 22C) pF, f in Hz, C in µF,

values range from 0.0001 pF to

2200 pF

 $(0.2/f + 14L) H \mu H$, f in Hz, 0 H to 1 H

L in H, values range from $0.0001 \, \mu H$ to $14 \, \mu H$

(f) Current transformer testing sets

Ratio/Phase

0 µF to 100 µF

(frequencies in the range 45 Hz to 65 Hz)

 $5.0 \times 10^{-7} \text{ to } 1.0 \times 10^{-6}$ Ratio error \pm (0 to 0.002) 2.0×10^{-6} to 8.0×10^{-6} Ratio error \pm (0.002 to 0.02) 2.0×10^{-5} to 8.0×10^{-5} Ratio error \pm (0.02 to 0.2)

 5.0×10^{-7} rad to 1.0×10^{-6} rad ± 0 rad to 0.002 rad Phase error $5.0 \times 10^{-6} \text{ rad to } 9.0 \times 10^{-6} \text{ rad}$ Phase error ± 0.002 rad to 0.02 rad $5.0 \times 10^{-5} \text{ rad to } 9.0 \times 10^{-5} \text{ rad}$ Phase error ± 0.02 rad to 0.2 rad

Voltage transformer testing sets (g)

Same as 5.90 (f)

(i) AC and DC bridges for thermometry

Resistance $0~\Omega$ to $400~\Omega$

(frequency, f = DC to 100 Hz)

 $(6 + 0.3 R) \mu\Omega$, R in Ω , values range from 6 $\mu\Omega$ to 126 $\mu\Omega$

Operations Manager Authorisation: 1310/8tro-

Issue 57

Date:07/08/20

Page **20** of **23**

Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

Resistance ratio $0 \Omega/\Omega$ to $13 \Omega/\Omega$ (frequency, f = DC to 100 Hz)

2.6 x 10⁻⁸

5.91 Frequency Measurement and Time Measurement

Time and frequency CMC uncertainties relate only to the reference measuring systems. These uncertainties do not contain any contribution from the instrument under calibration.

(a) Frequency meters

(c) Counters

(d) Time interval meters

10 ns to 86400 s 2 ns or 0.27 ps/s, whichever is

greatest

(g) Frequency standards

100 kHz to 10 MHz 2 x 10⁻¹³ 0.001 Hz to 1 Hz (period) 1 ns

5.92 Waveform Measurement

(a) Frequency characteristics

(b) Input characteristics

1 V and 3 V 0.16 mV/V to 2.6 mV/V

(frequency, f = 1 MHz to 100 MHz)

Pulse risetime (*T*>5 ns) (10 mV to 10 V)

 $0.005~\mu s$ to $1.00~x~10^6~\mu s$ Q(2 ns, 0.05~T), T in s

Operations Manager Authorisation: 1 HOBERO

Issue 57

Date:07/08/20

Page **21** of **23**

Schedule to





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Metrolog	n Innovation y & Calibration Laboratory OF ACCREDITATION	Accreditation Number 1	
	Pulse amplitude (pulse length > 200 μs) (10 mV, 100 mV, 1 V, 10 V)		
	0 V to 10 V	(30 μV+ 100 Va + 420 Vr), applied voltage Va in V, voltmeter range Vr in V, values range from 34.2 μV to 5230 μV	
	(c) Timing characteristics		
	10 ns to 100 s (time difference)	2 ns	
5.93	Signal Sources		
	(a) Frequency characteristics		
	1 Hz to 20 MHz 0.001 Hz to 1 Hz (period)	1 x 10 ⁻¹⁰ 1 ns	
	(b) Output characteristics		
	1 V and 3 V (frequency, f = 1 MHz to 100 MHz)	0.16 mV/V to 2.6 mV/V	
	Pulse amplitude (pulse length > 200 μs) (10 mV, 100 mV, 1 V, 10 V)		
	0 V to 10 V	(30 μ V + 100 Va + 420 Vr) applied voltage Va in V, voltmeter range Vr in V, values range from 34.2 μ V to 5230 μ V	
	Pulse risetime ($T > 5$ ns) (10 mV to 10 V)		
	0.005 μs to 1.00 x 10 ⁶ μs	Q(2 ns, 0.05 <i>T</i>), <i>T</i> in s	
5.97	High Voltage Testing		
	(a) Direct voltage		
	0 kV to 50 kV	3 mV/V	
	(b) Alternating voltage		
	1 kV rms to 35 kV rms	1 mV/V	

Schedule to

CERTIFICATE OF ACCREDITATION





Callaghan Innovation
Metrology & Calibration Laboratory
SCOPE OF ACCREDITATION

Accreditation Number 1

(frequency, f = 50 Hz to 3 kHz)

Note 1:

A CMC anticipates the performance of a best available device. Measurement uncertainties achieved for specific calibrations may be greater than CMC uncertainties, but a laboratory may not report measurement uncertainties lower than those in its CMCs. Please contact the laboratory to discuss your specific requirements.

Operations Manager Authorisation:

1 GOPTO-

Issue 57

Date:07/08/20

Page 23 of 23